

**Search Notes**

Application/Control No.

10/675,555

Examiner

Steven Loke

Applicant(s)/Patent under  
Reexamination

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Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	529, 528, 153	11/2/2004	TM
438	132, 215	11/2/2004	TM
438	601, 281	11/2/2004	TM
updated	searched	2/20/2006	sl

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR